Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/679,290	SHISHIDO ET AL.	
Examiner	Art Unit	
ALEX LIEW	2624	

	SEARCHED					
Class	Subclass	Date	Examiner			

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
	<u> </u>				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
382/141-152,154 limited to text search	3/7/2007	AL		
382/141-152,154 limited to text search	9/13/2007	AL		
382/141-152,154 limited to text search	3/12/2008	AL		